

SIGC121T120R2CL

IGBT Chip in NPT-technology

FEATURES:

- 1200V NPT technology
- 180µm chip
- low turn-off losses
- positive temperature coefficient
- easy paralleling
- integrated gate resistor

This chip is used for:

 power module BSM75GD120DLC

Applications:

drives



Chip Type	\mathbf{V}_{CE}	I Cn	Die Size	Package	Ordering Code
SIGC121T120R2CL	1200V	75A	11.08 X 11.08 mm ²	sawn on foil	Q67041- A4686-A003

MECHANICAL PARAMETER:

Raster size	11.08 X 11.08		
Emitter pad size	8 x (2.99 x 1.97)	-	
Gate pad size	1.46 x 0.8	-	
Area total / active	122.8 / 99.6	-	
Thickness	180	μm	
Wafer size	150	mm	
Flat position	90	grd	
Max.possible chips per wafer	104 pcs		
Passivation frontside	Photoimide		
Emitter metallization	3200 nm Al Si 1%		
Collector metallization	1400 nm Ni Ag –system suitable for epoxy and soft solder die bonding		
Die bond	electrically conductive glue or solder		
Wire bond	Al, <500µm		
Reject Ink Dot Size	Ø 0.65mm ; max 1.2mm		
Recommended Storage Environment	store in original container, in dry nitrogen, < 6 month at an ambient temperature of 23°C		



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MAXIMUM RATINGS:

Parameter	Symbol	Value	Unit
Collector-emitter voltage, T _j =25 °C	V _{CE}	1200	V
DC collector current, limited by T _{jmax}	I _C	1)	А
Pulsed collector current, t _p limited by T _{jmax}	I _{cpuls}	225	А
Gate emitter voltage	V _{GE}	±20	V
Operating junction and storage temperature	T _j , T _{stg}	-55 +150	°C

¹⁾ depending on thermal properties of assembly

STATIC CHARACTERISTICS (tested on chip), T_j =25 °C, unless otherwise specified:

Parameter	Symbol	Conditions	Value			Unit
	Cymbol	Conditions	min.	typ.	max.	•
Collector-emitter breakdown voltage	V _{(BR)CES}	V_{GE} =0V , I _C =4mA	1200			
Collector-emitter saturation voltage	V _{CE(sat)}	V _{GE} =15V, I _C =75A	1.8	2.2	2.6	V
Gate-emitter threshold voltage	V _{GE(th)}	$I_C=3mA$, $V_{GE}=V_{CE}$	4.5	5.5	6.5	
Zero gate voltage collector current	I _{CES}	V_{CE} =1200V , V_{GE} =0V			9.2	μA
Gate-emitter leakage current	I _{GES}	V _{CE} =0V , V _{GE} =20V			480	nA
Integrated gate resistor	R _{Gint}			5		Ω

ELECTRICAL CHARACTERISTICS (tested at component):

Parameter	Symbol	Symbol Conditions	Value			Unit
rarameter	Symbol	Conditions	min.	typ.	max.	onn
Input capacitance	Ciss	V _{CE} =25V,	-	5.1	-	nF
Output capacitance	Coss	$V_{GE}=0V$,	-	-	-	
Reverse transfer capacitance	Crss	f=1MHz	-	0.33	-	

SWITCHING CHARACTERISTICS (tested at component), Inductive Load

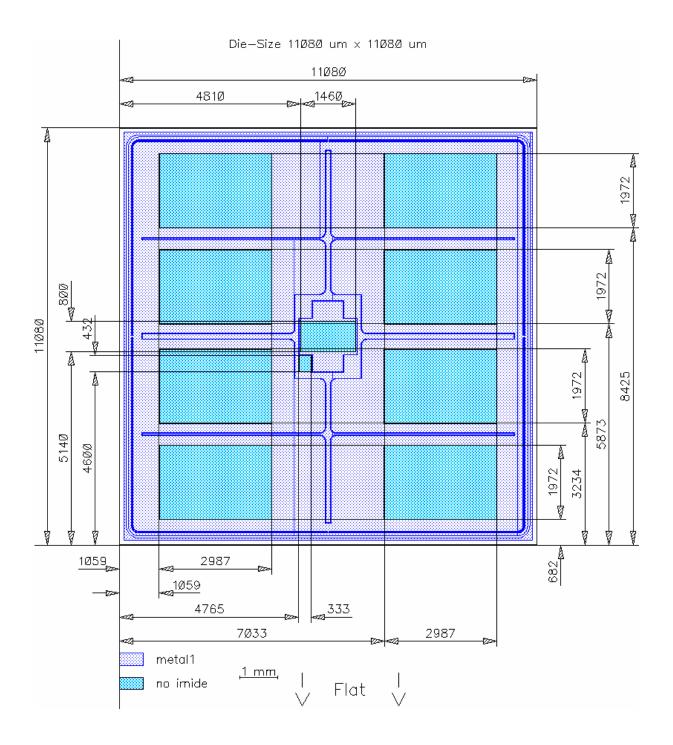
Parameter	Symbol	Conditions ¹⁾	Value			Unit
i alameter	Cymbol		min.	typ.	max.	
Turn-on delay time	t _{d(on)}	<i>T</i> _j =125°C	-	60	-	ns
Rise time	tr	V _{CC} =600V, I _C =75A,	-	50	-	
Turn-off delay time	$t_{d(off)}$	$V_{GE}=\pm 15V,$	-	350	-	
Fall time	t _f	$R_{\rm G}$ =10 Ω	-	70	-	

¹⁾ values also influenced by parasitic L- and C- in measurement and package.





CHIP DRAWING:





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FURTHER ELECTRICAL CHARACTERISTICS:

This chip data sheet refers to the device data sheet	BSM75GD120DLC	Package Econopack 3
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DESCRIPTION:

AQL 0,65 for visual inspection according to failure catalog

Electrostatic Discharge Sensitive Device according to MIL-STD 883

Test-Normen Villach/Prüffeld

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